

INSPECTION SUBSTRATE AND INSPECTING METHOD

ABSTRACT OF THE DISCLOSURE

An inspection substrate for use in inspecting a laser beam for leakage light, the laser beam having a transmission wavelength to the inspection substrate, the inspection substrate includes a first surface to which the laser beam is to be applied, a second surface opposite to the first surface, a street set on the second surface, a plurality of first inspection wires provided on the second surface so as to extend along the street, the first inspection wires being located at different distances from the street, and a plurality of first electrode pads provided on each of the first inspection wires so as to be spaced from each other in a direction along the street.

[Fig. 2]